Practical Applications of Model-Driven Engineering

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Message from the Guest Editors

Model-driven engineering (MDE) began as a software development methodology but has since been extended to a wide range of applications, also in the science of electronics and its applications. MDE promotes the usage of high-level and domain-specific modeling languages together with automatic transformations to improve all the activities during the development lifecycle.

This Special Issue will be a forum to share practical applications of MDE and concrete experiences in information and control systems, both in critical and non-critical domains. In this context, we are envisaging works covering one or more of the following topics...

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Special Issue

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Message from the Editor-in-Chief

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